

**Notice of References Cited**

Application/Control No.

10/577,100

Applicant(s)/Patent Under  
Reexamination  
HEERTJES ET AL.

Examiner

KIM CHU

Art Unit

2627

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,215,606	05-2007	Yonezawa, Minoru	369/44.29
*	B	US-6,437,936	08-2002	Chen et al.	360/77.04
*	C	US-5,982,721	11-1999	Supino et al.	369/44.29
*	D	US-5,367,513	11-1994	Bates et al.	369/44.29
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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